

# SANYO Semiconductors DATA SHEET

# EMH2402 — General-Purpose Switching Device Applications

# Features

- The EMH2402 incorporates an N-channel MOSFET that feature low ON-resistance and ultrahigh-speed switching, thereby enabling high-density mounting.
- 4V drive.

# **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	P-channel	Unit
Drain-to-Source Voltage	VDSS		30	V
Gate-to-Source Voltage	VGSS		±20	V
Drain Current (DC)	۱ <sub>D</sub>		3.5	А
Drain Current (Pulse)	IDP	PW≤10µs, duty cycle≤1%	14	А
Allowable Power Dissipation	PD	Mounted on a ceramic board (900mm <sup>2</sup> X0.8mm) 1unit	1.0	W
Total Dissipation	PT	Mounted on a ceramic board (900mm <sup>2</sup> X0.8mm)	1.2	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

#### Electrical Characteristics at Ta=25°C

Symbol	Conditions		Ratings		
		min	typ	max	Unit
V(BR)DSS	ID=1mA, VGS=0V	30			V
IDSS	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μA
IGSS	V <sub>GS</sub> =±16V, V <sub>DS</sub> =0V			±10	μA
VGS(off)	VDS=10V, ID=1mA	1.2		2.6	V
yfs	V <sub>DS</sub> =10V, I <sub>D</sub> =2A	1.5	2.6		S
R <sub>DS</sub> (on)1	ID=2A, VGS=10V		53	69	mΩ
RDS(on)2	ID=1A, VGS=4V		105	150	mΩ
Ciss	V <sub>DS</sub> =10V, f=1MHz		280		pF
Coss	V <sub>DS</sub> =10V, f=1MHz		60		pF
Crss	VDS=10V, f=1MHz		47		pF
t <sub>d</sub> (on)	See specified Test Circuit.		8.6		ns
tr	See specified Test Circuit.		25.5		ns
td(off)	See specified Test Circuit.		23.0		ns
tf	See specified Test Circuit.		13.5		ns
	V(BR)DSS           IDSS           IGSS           VGS(off)            yfs            RDS(on)2           Ciss           Coss           Crss           td(on)           tr           td(off)	V(BR)DSS         ID=1mA, VGS=0V           IDSS         VDS=30V, VGS=0V           IGSS         VGS=±16V, VDS=0V           VGS(off)         VDS=10V, ID=1mA            yfs          VDS=10V, ID=2A           RDS(on)1         ID=2A, VGS=10V           Ciss         VDS=10V, f=1MHz           Coss         VDS=10V, f=1MHz           Crss         VDS=10V, f=1MHz           td(on)         See specified Test Circuit.           tr         See specified Test Circuit.           td(off)         See specified Test Circuit.	Min         min           V(BR)DSS         ID=1mA, VGS=0V         30           IDSS         VDS=30V, VGS=0V         30           IGSS         VGS=±16V, VDS=0V         10           VGS(off)         VDS=10V, ID=1mA         1.2           Iyfs         VDS=10V, ID=2A         1.5           RDS(on)1         ID=2A, VGS=10V         10           Ciss         VDS=10V, f=1MHz         10           Coss         VDS=10V, f=1MHz         10           Crss         VDS=10V, f=1MHz         10           td(on)         See specified Test Circuit.         10           tr         See specified Test Circuit.         10           td(off)         See specified Test Circuit.         10	$\begin{tabular}{ c c c c } \hline Conditions & \hline min & typ \\ \hline \hline \ min & typ \\ \hline \hline \ min & typ \\ \hline \hline \hline \ \ min & typ \\ \hline \hline \hline \ \hline \hline \hline \hline \hline \ \hline \ \hline \ \hline \ \hline \ \hline$	$\begin{tabular}{ c c c c c } \hline Conditions & \hline min & typ & max \\ \hline min & typ & typ & max \\ \hline min & typ & typ & typ & typ \\ \hline max & typ & typ & typ & typ & typ & typ \\ \hline max & typ & ty$

Marking : LB

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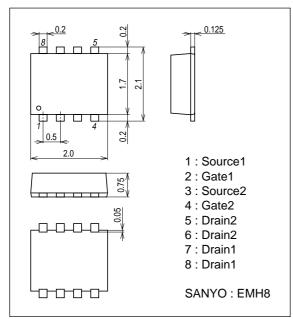
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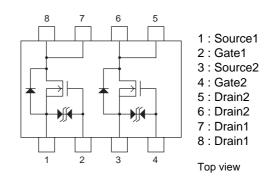
Parameter	Symbol	Conditions	Ratings			Unit
	Symbol		min	typ	max	Unit
Total Gate Charge	Qg	VDS=10V, VGS=10V, ID=3.5A		6.4		nC
Gate-to-Source Charge	Qgs	V <sub>DS</sub> =10V, V <sub>GS</sub> =10V, I <sub>D</sub> =3.5A		1.35		nC
Gate-to-Drain "Miller" Charge	Qgd	VDS=10V, VGS=10V, ID=3.5A		1.05		nC
Diode Forward Voltage	VSD	IS=3.5A, VGS=0V		0.85	1.2	V

#### **Package Dimensions**

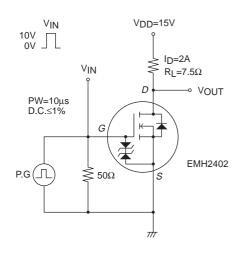
unit : mm 7045-002

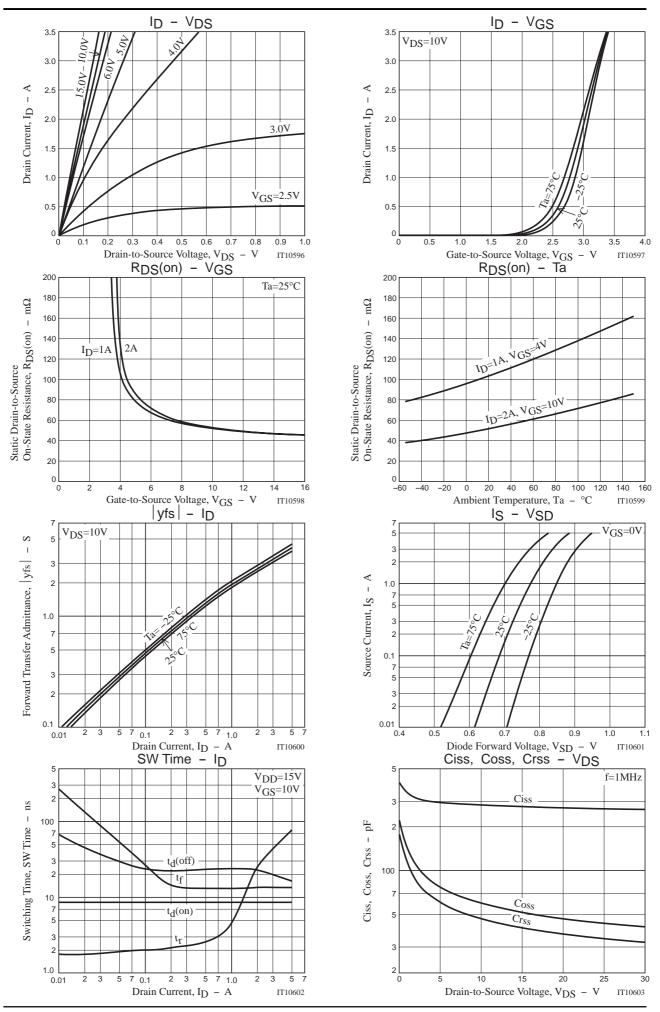


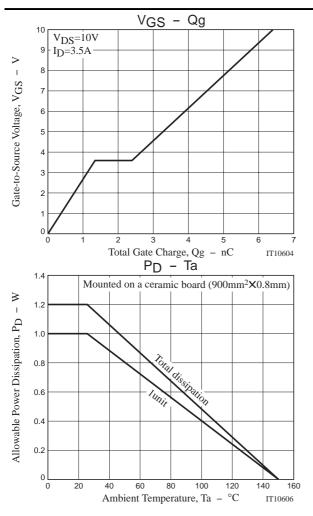
## **Electrical Connection**

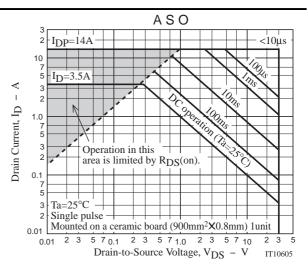


## **Switching Time Test Circuit**









Note on usage : Since the EMH2402 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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